

## Features

- Split Gate Trench MOSFET technology
- Excellent package for heat dissipation
- High density cell design for low  $R_{DS(ON)}$

## Product Summary

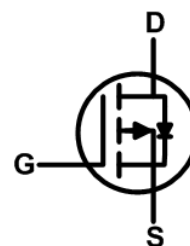
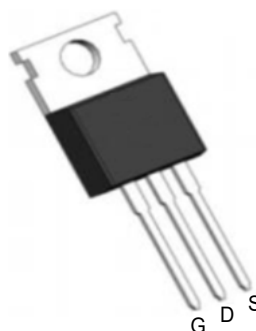


BVDSS	RDSON	ID
-100V	12.5mΩ	-120A

## Applications

- Battery switching application
- Hard switched and high frequency circuits
- Power management

## TO220AB Pin Configuration



## Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
$V_{DS}$	Drain-Source Voltage	-100	V
$V_{GS}$	Gate-Source Voltage	$\pm 20$	V
$I_D @ T_C = 25^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ 10V^{1,6}$	-120	A
$I_D @ T_C = 100^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ 10V^{1,6}$	-64	A
$I_{DM}$	Pulsed Drain Current <sup>2</sup>	-600	A
EAS	Single Pulse Avalanche Energy <sup>3</sup>	1458	mJ
$I_{AS}$	Avalanche Current	---	A
$P_D @ T_C = 25^\circ\text{C}$	Total Power Dissipation <sup>4</sup>	300	W
$T_{STG}$	Storage Temperature Range	-55 to 150	$^\circ\text{C}$
$T_J$	Operating Junction Temperature Range	-55 to 150	$^\circ\text{C}$

## Thermal Data

Symbol	Parameter	Typ.	Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction-Ambient <sup>1</sup>	---	60	$^\circ\text{C/W}$
$R_{\theta JC}$	Thermal Resistance Junction-Case <sup>1</sup>	---	0.45	$^\circ\text{C/W}$

**Electrical Characteristics ( $T_J=25^\circ\text{C}$ , unless otherwise noted)**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0V$ , $I_D=-250\mu A$	-100	---	---	V
$\Delta BV_{DSS}/\Delta T_J$	$BV_{DSS}$ Temperature Coefficient	Reference to $25^\circ\text{C}$ , $I_D=1mA$	---	---	---	V/ $^\circ\text{C}$
$R_{DS(ON)}$	Static Drain-Source On-Resistance <sup>2</sup>	$V_{GS}=-10V$ , $I_D=-22A$	---	12.5	15.6	m $\Omega$
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}=V_{DS}$ , $I_D=-250\mu A$	-2	-3	-4	V
$\Delta V_{GS(th)}$	$V_{GS(th)}$ Temperature Coefficient		---	---	---	mV/ $^\circ\text{C}$
$I_{DSS}$	Drain-Source Leakage Current	$V_{DS}=-100V$ , $V_{GS}=0V$ , $T_J=25^\circ\text{C}$	---	---	1	$\mu A$
		$V_{DS}=-100V$ , $V_{GS}=0V$ , $T_J=100^\circ\text{C}$	---	---	---	
$I_{GSS}$	Gate-Source Leakage Current	$V_{GS}=\pm 20V$ , $V_{DS}=0V$	---	---	$\pm 100$	nA
$g_{fs}$	Forward Transconductance	$V_{DS}=-10V$ , $I_D=-5A$	---	---	---	S
$R_g$	Gate Resistance	$V_{DS}=0V$ , $V_{GS}=0V$ , $f=1MHz$	---	---	---	$\Omega$
$Q_g$	Total Gate Charge	$V_{DS}=-50V$ , $V_{GS}=-10V$ , $I_D=-5A$	---	136	---	nC
$Q_{gs}$	Gate-Source Charge		---	36	---	
$Q_{gd}$	Gate-Drain Charge		---	24.8	---	
$T_{d(on)}$	Turn-On Delay Time	$V_{GS}=-10V$ , $V_{DS}=-50V$ , $I_D=-22A$ , $R_G=1\Omega$	---	18	---	ns
$T_r$	Rise Time		---	43	---	
$T_{d(off)}$	Turn-Off Delay Time		---	125	---	
$T_f$	Fall Time		---	43	---	
$C_{iss}$	Input Capacitance	$V_{DS}=-50V$ , $V_{GS}=0V$ , $f=1MHz$	---	9349	---	pF
$C_{oss}$	Output Capacitance		---	798	---	
$C_{rss}$	Reverse Transfer Capacitance		---	111.2	---	

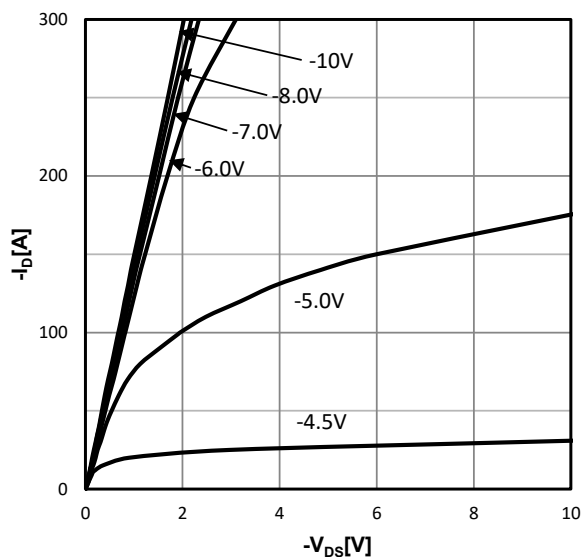
**Diode Characteristics**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$I_S$	Continuous Source Current <sup>1,4</sup>	$V_G=V_D=0V$ , Force Current	---	---	-120	A
$V_{SD}$	Diode Forward Voltage <sup>2</sup>	$V_{GS}=0V$ , $I_S=-20A$ , $T_J=25^\circ\text{C}$	---	---	-1.2	V
$t_{rr}$	Reverse Recovery Time	$I_F=-20A$ , $di/dt=100A/\mu s$	---	107	---	nS
$Q_{rr}$	Reverse Recovery Charge	$\mu s$ , $T_J=25^\circ\text{C}$	---	216.8	---	nC

a1: Repetitive rating; pulse width limited by maximum junction temperature  
a2:  $V_{DD}=-50V$ ,  $L=1mH$ ,  $R_G=25\Omega$ , Starting  $T_J=25^\circ\text{C}$

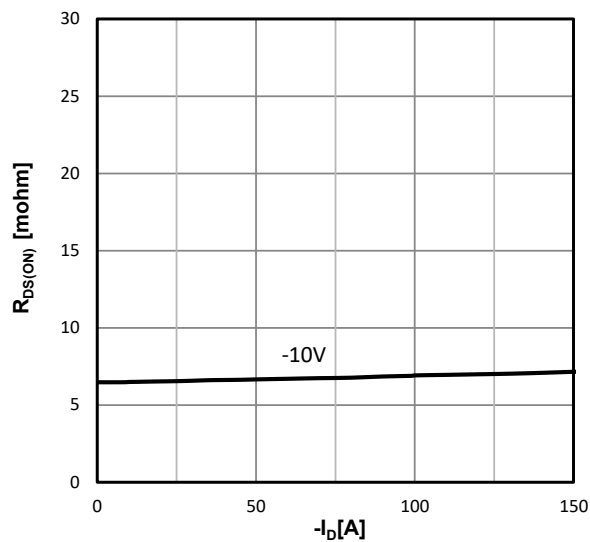
### Characteristics Curve:

Figure 1: Typ. output characteristics



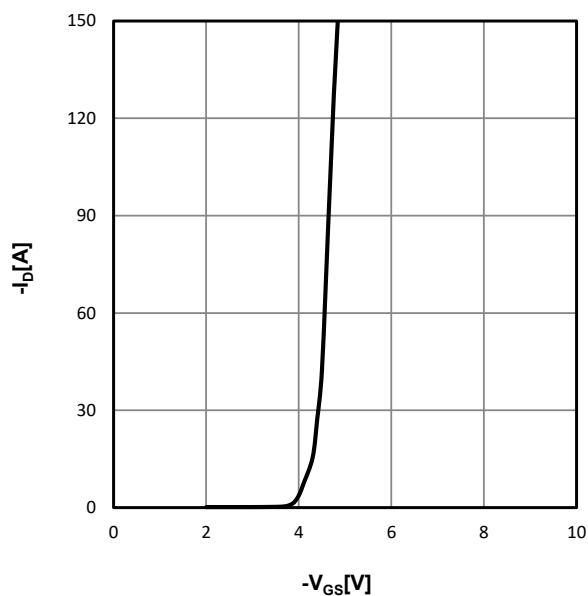
$$I_D = f(V_{DS}), T_j = 25^\circ\text{C}; \text{parameter: } V_{GS}$$

Figure 2: Typ. drain-source on resistance



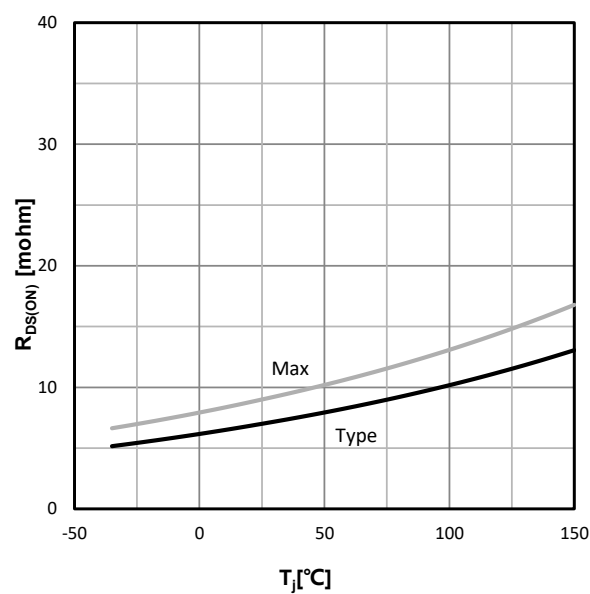
$$R_{DS(on)} = f(I_D), T_j = 25^\circ\text{C}; \text{parameter: } V_{GS}$$

Figure 3: Typ. transfer characteristics



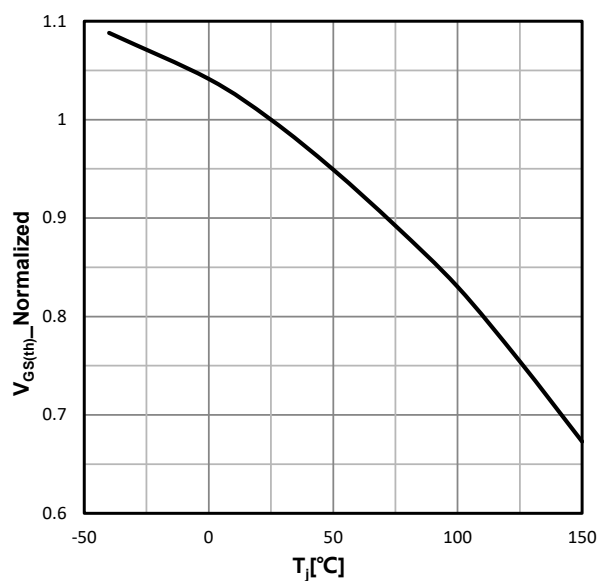
$$I_D = f(V_{GS}), |V_{DS}| > 2|I_D|R_{DS(on)\text{max}};$$

Figure 4: drain-source on resistance



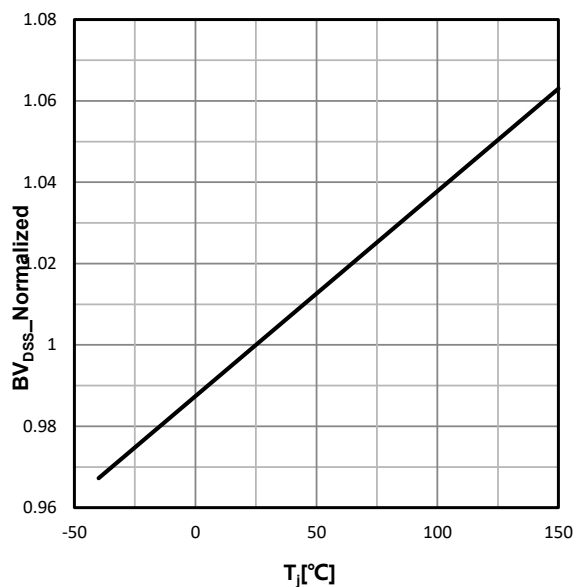
$$R_{DS(on)} = f(T_j), I_D = -20\text{A}, V_{GS} = -10\text{V};$$

Figure 5: Typ. gate threshold voltage



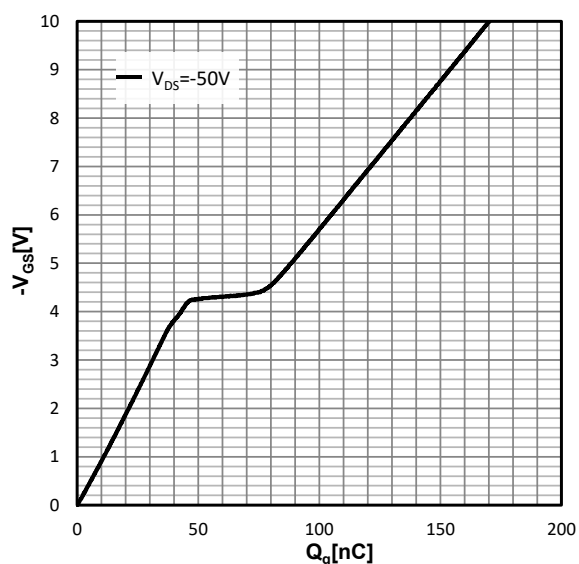
$$V_{GS}=f(T_j), V_{GS}=V_{DS}, I_D=-250\mu A;$$

Figure 6: Drain-source breakdown voltage



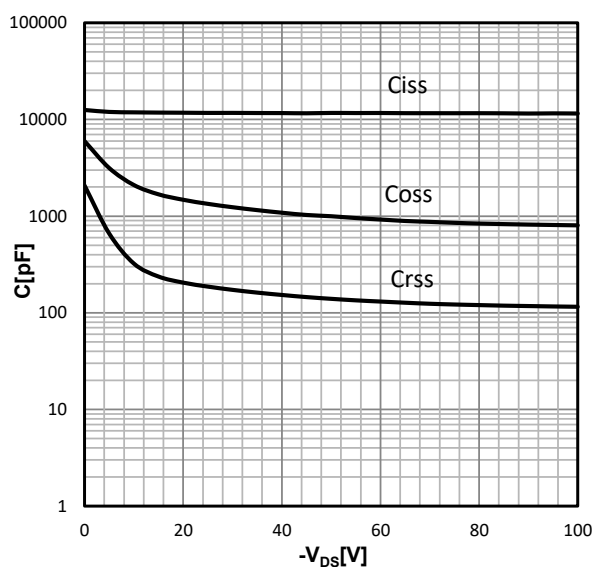
$$V_{BR(DSS)}=f(T_j); I_D=-250\mu A;$$

Figure 7: Typ. gate charge



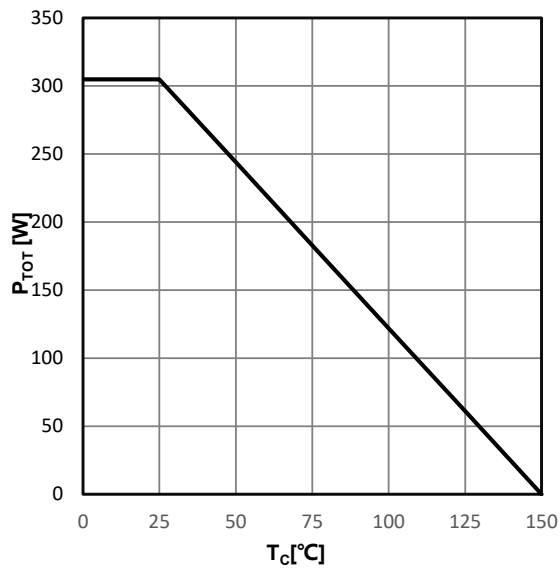
$$V_{GS}=f(Q_g), I_D=-20A, T_j=25^{\circ}C; \text{parameter: } V_{DS}$$

Figure 8: Typ. Capacitances



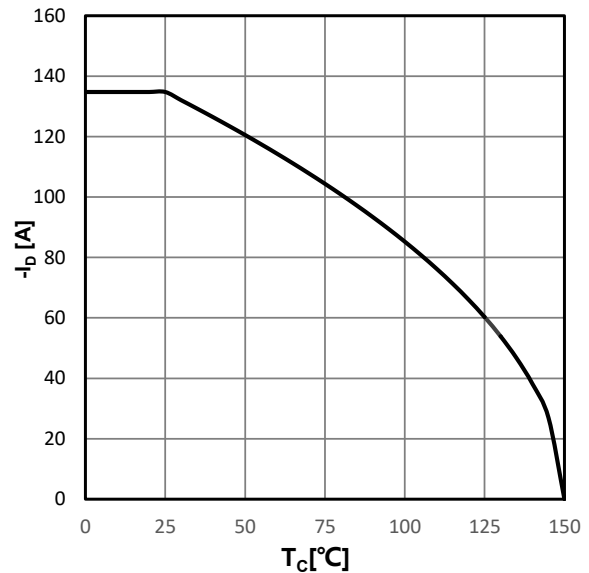
$$C=f(V_{DS}); V_{GS}=0V; f=1.0\text{ MHz};$$

Figure 9: Power dissipation



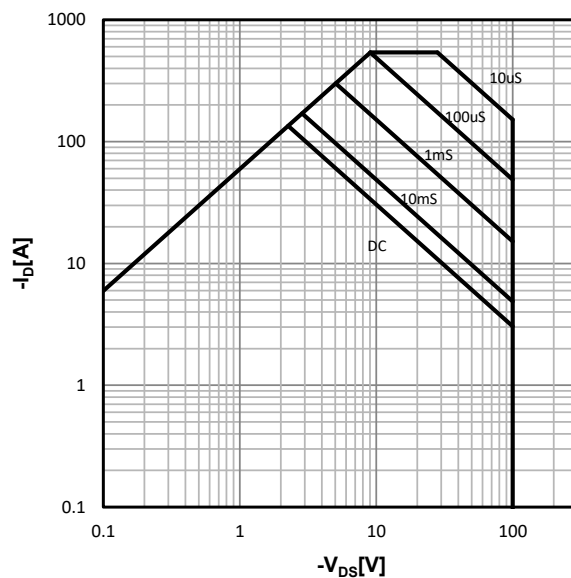
$$P_{\text{tot}} = f(T_c);$$

Figure 10: Drain current



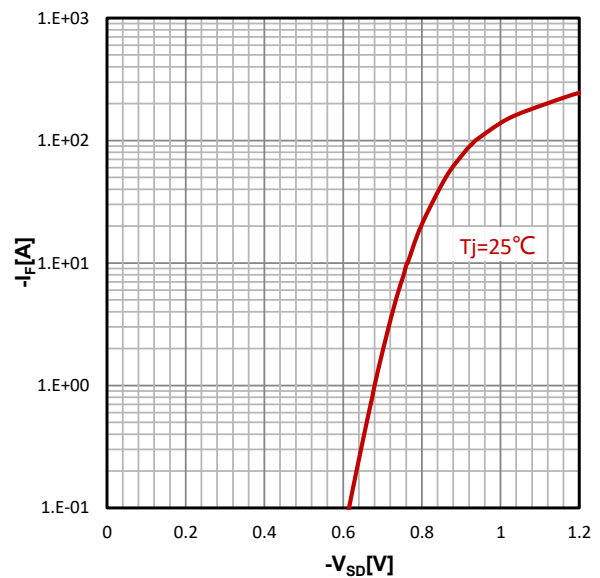
$$I_D = f(T_c);$$

Figure 11: Safe operating area



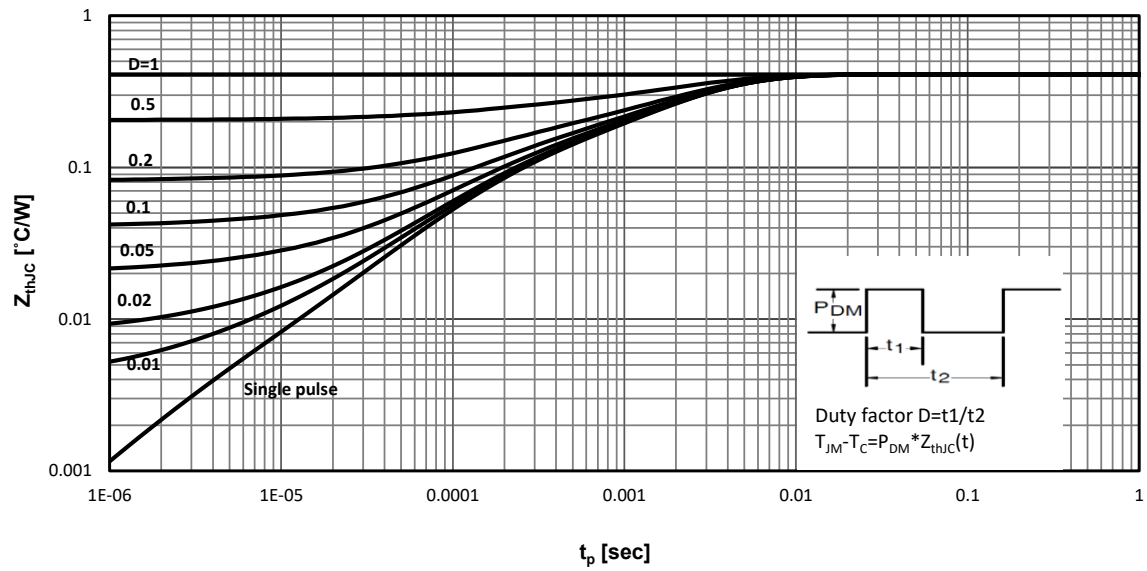
$$I_D = f(V_{\text{DS}}); T_c = 25^{\circ}\text{C}; D = 0; \text{parameter: } t_p$$

Figure 12: Typ. forward characteristics



$$I_F = f(V_{\text{SD}});$$

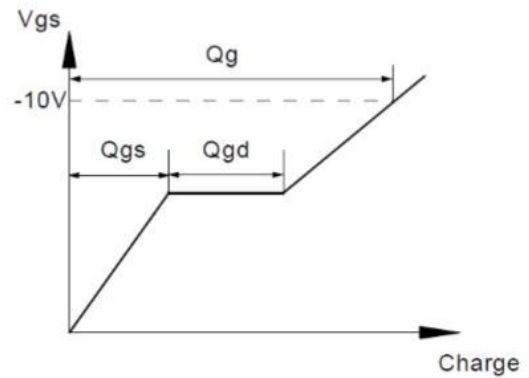
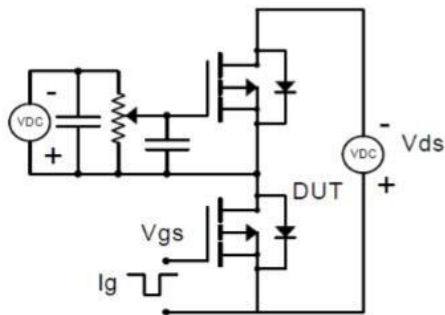
Figure 13: Max. Transient Thermal Impedance



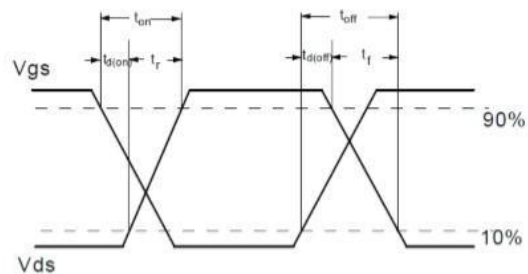
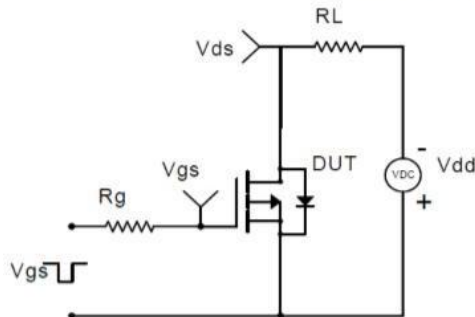
$$Z_{thJC} = f(t_p); \text{ parameter: } D$$

### Test Circuit and Waveform:

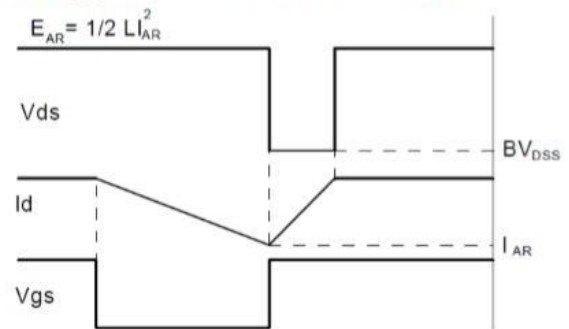
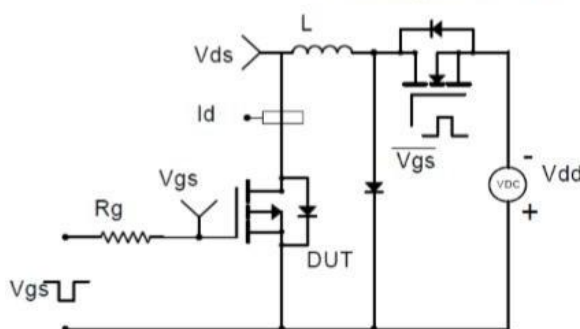
Gate Charge Test Circuit & Waveform



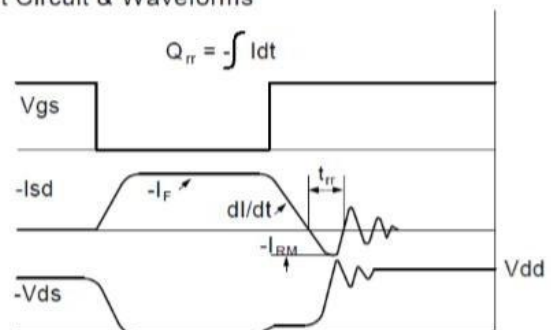
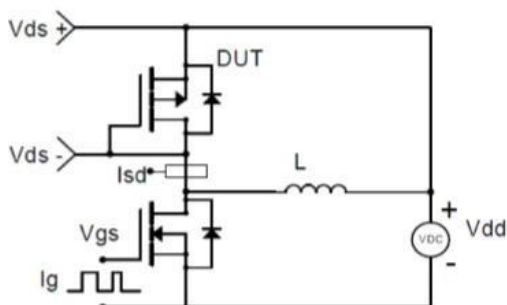
Resistive Switching Test Circuit & Waveforms



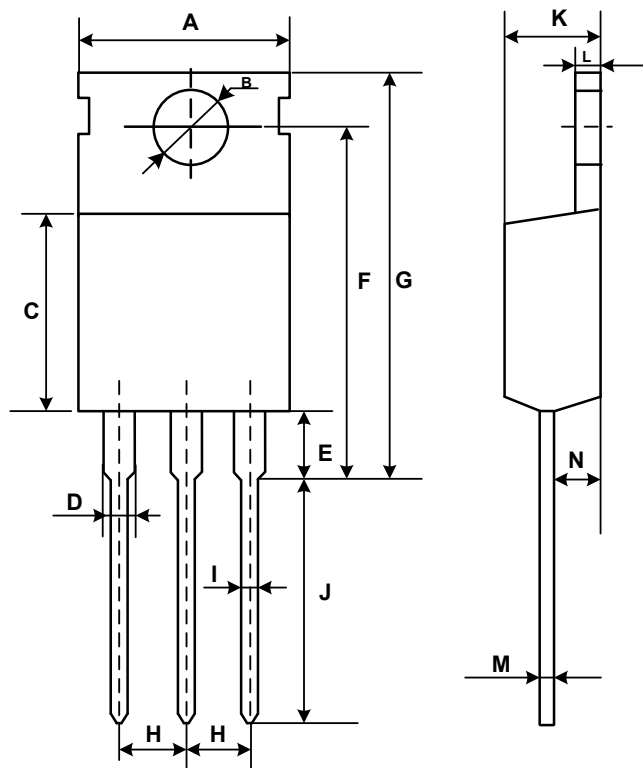
Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms



Mechanical Dimensions for TO-220



COMMON DIMENSIONS

SYMBOL	MM	
	MIN	MAX
A	9.70	10.30
B	3.40	3.80
C	8.80	9.40
D	1.17	1.47
E	2.60	3.50
F	15.10	16.70
G	19.55MAX	
H	2.54REF	
I	0.70	0.95
J	9.35	11.00
K	4.30	4.77
L	1.20	1.45
M	0.40	0.65
N	2.20	2.60